

FCC RF Test Report

Product Name: Smart Phone

Model Number: FIG-LX1

Report No.: SYBH(Z-RF)001112017-2001 FCC ID: QISFIG-LX1

Reliability Laboratory of Huawei Technologies Co., Ltd.

(Global Compliance and Testing Center of Huawei Technologies Co., Ltd)

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Notice

1. The laboratory has passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.

2. The laboratory has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01

3. The laboratory has been recognized by the US Federal Communications Commission (FCC) to perform compliance testing subject to the Commission's Certification rules. The Designation Number is CN1173, and the Test Firm Registration Number is 294140.

4. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-1.

5. The laboratory (Reliability Lab of Huawei Technologies Co., Ltd) is also named "Global Compliance and Testing Center of Huawei Technologies Co., Ltd", the both names have coexisted since 2009.

6. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.

7. The test report is invalid if there is any evidence of erasure and/or falsification.

8. The test report is only valid for the test samples.

9. Content of the test report, in part or in full, cannot be used for publicity and/or promotional

purposes without prior written approval from the laboratory.



Applicant:	Huawei Technologies Co., Ltd.
Address:	Administration Building, Headquarters of Huawei Technologies Co., Ltd.,
	Bantian, Longgang District, Shenzhen, 518129, P.R.C

Date of Receipt Sample:	2017-11-6
Start Date of Test:	2017-11-6
End Date of Test:	2017-11-27

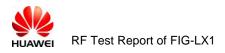
Test Result: Pass

Approved by Senior	2017-11-27	Roger zhang	Roger Thang
Engineer:	Date	Name	Signature
			-
Prepared by:	2017-11-27	Mao Wenli	M aowenli
	Date	Name	Signature



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1 <u>General Information</u>

1.1 Applied Standard	
Applied Rules:	47 CFR FCC Part 02
	47 CFR FCC Part 22
	47 CFR FCC Part 24
	47 CFR FCC Part 27
Test Method:	FCC KDB 971168 D01 Power Meas License Digital Systems v03
1.2 Test Location	
Test Location :	Reliability Laboratory of Huawei Technologies Co., Ltd.
Address:	Administration Building, Headquarters of Huawei Technologies Co., Ltd.,
	Bantian, Longgang District, Shenzhen, 518129, P.R.C
1.3 Test Environment Co	ondition
Ambient Temperature:	19.5 to 25 °C
Ambient Relative Humidity:	40 to 55 %
Atmospheric Pressure:	Not applicable



2 Test Summary

2.1 Cellular Band (824-849 MHz paired with 869-894 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913	FCC: ERP ≤ 7 W.	Appendix A	Pass
Peak-Average Ratio		Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §22.917	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	Pass
Spurious Emission at Antenna Terminals	§2.1051, §22.917	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Appendix F	Pass
Field Strength of Spurious Radiation	§2.1053, §22.917	FCC: ≤ -13 dBm/100 kHz.	Appendix G	Pass
Frequency Stability	§2.1055, §22.355	≤ ±2.5ppm.	Appendix H	Pass
NOTE 1: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".				

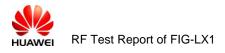
2.2 PCS Band (1850-1910 MHz paired with 1930-1990 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	EIRP ≤ 2 W	Appendix A	Pass
Peak-Average Ratio	§2.1046, §24.232	Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §24.238	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	Pass
Spurious Emission at Antenna Terminals	§2.1051, §24.238	 ≤ -13 dBm/1 MHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges. 	Appendix F	Pass
Field Strength of Spurious Radiation	§2.1053, §24.238	≤ -13 dBm/1 MHz.	Appendix G	Pass
Frequency Stability	§2.1055, §24.235	≤ ±2.5 ppm.	Appendix H	Pass
NOTE 1:For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".				



2.3 BRS&EBS Band (2500-2570 MHz paired with 2620-2690 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP ≤ 2W	Appendix A	Pass
Peak-Average Ratio	§27.50(a)	Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §27.53(m4)	FCC 2%*EBW Channel 2%*EBW 10dBm Edge 10dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 13dBm 10dBm 120 10dBm 120 10	Appendix E	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	9 kHz 25 dBm/ 1 MHz 9 kHz 25 dBm/ 1 MHz 9 kHz 25 dBm/ 1 MHz 1	Appendix F	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	P kHz 95 MHz XMHz 10th harmonics X=Max {6MHz, EBW}	Appendix G	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block. Appendix H Pass		
NOTE 1: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".				



3 Description of the Equipment under Test (EUT)

3.1 General Description

FIG-LX1 is subscriber equipment in the LTE/WCDMA/GSM system. The LTE frequency band for Single Carrier is LTE band1,LTE band 3,LTE band 7,LTE band 8,LTE band 20 and the LTE frequency band for carrier aggregation downlink operation band is inter-band CA_3-7,CA_7-20, CA_3-20 and intra-band contiguous CA_1,CA_3,CA_7 and intra-band non-contiguousCA_3. The HSPA/UMTS frequency band is Band 1,Band 2,Band 5 and Band 8. The GSM/GPRS/EDGE frequency band includes GSM850,GSM900, DCS1800 and PCS1900. The Mobile Phone implements such functions as RF signal receiving/transmitting, HSPA/UMTS and GSM/GPRS/EDGE protocol processing, voice, video, MMS service, GPS, AGPS and WIFI etc.

Note: Only GSM850/1900&WCDMA850/1900<E band 7 test data included in this report.

3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

3.2.1 Board

Board			
Description	Hardware Version	Software Version	
Main Board	HL3FIGOM	FIG-LX1 8.0.0.100 (C900)	

3.2.2 Sub-Assembly

Sub-Assembly			
Sub-Assembly	Model	Manufacturer	Description
Name	Woder	Mandiaetarer	Description
		Huawei	Input Voltage: 100-240V 50/60Hz 0.5A
Adapter	HW-050200E01	Technologies	Output Voltage: 5V === 2A
		Co., Ltd.	Rated Power: 10W
			Rated capacity: 2900mAh
Battery	HB366481ECW-11	Huawei Technologies	Nominal Voltage: +3.82V
		Co., Ltd.	Charging Voltage: 4.4V



3.3 Technical Specification

Characteristics	Description		
Radio System Type	GSM		
	🖾 UMTS		
	🖾 LTE		
Supported Frequency Range	GSM850/ WCDMA850	Transmission (TX):	824 to 849 MHz
	GSINIOSO/ WCDINIAOSO	Receiving (RX):	869 to 894 MHz
	GSM1900/ WCDMA1900	Transmission (TX):	1850 to 1910 MHz
	GSINIT900/ WCDINA T900	Receiving (RX):	1930 to 1990 MHz
	LTE BAND7	Transmission (TX):	2500 to 2570 MHz
		Receiving (RX):	2620 to 2690 MHz
TX and RX Antenna Ports	TX & RX port:	1	
	TX-only port:	0	
	RX-only port:	1	
Target TX Output Power	GSM850: 32.5dBm		
	GSM1900 29.5dBm		
	UMTS850 22.8dBm		
	UMTS1900: 22.5dBm		
	LTE Band 7: 22.3dBm		
Supported Channel Bandwidth	GSM system:	🛛 200 kHz	
	UMTS system:	🖾 5 MHz	
	LTE band 7	⊠5MHz, ⊠10MHz ,	⊠15MHz ,⊠20MHz
Designation of Emissions	GSM850:	246KGXW, 248KG7V	V
(Note: the necessary bandwidth of	GSM1900:	250KGXW, 248KG7V	V
which is the worst value from the	UMTS850:	4M15F9W	
measured occupied bandwidths for	UMTS1900:	4M15F9W	
each type of channel bandwidth	LTE BAND7:	4M53G7D (5 MHz QF	PSK modulation),
configuration.)		4M58W7D (5 MHz 16	QAM modulation)
		9M00G7D (10 MHz G	PSK modulation),
		9M12W7D (10 MHz 1	6QAM modulation)
		13M6G7D (15 MHz Q	PSK modulation),
		13M6W7D (15 MHz 16QAM modulation)	
		18M1G7D (20 MHz QPSK modulation),	
		18M2W7D (20 MHz 1	6QAM modulation)



4 General Test Conditions / Configurations

4.1 Test Modes

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation
GSM/TM2	GSM system, EDGE, 8PSK modulation
UMTS/TM1	WCDMA system, QPSK modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation

4.2 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN Ambient	
	VL	3.6V
Voltage	VN	3.8V
	VH	4.35V

NOTE: VL= lower extreme test voltage VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature



4.3 Test Frequency

Test Mode	TY / DY	RF Channel				
Test Mode	TX/RX	Low (L)	Middle (M)	High (H)		
		Channel 128	Channel 190	Channel 251		
GSM850	ТХ	824.2MHz	836.6MHz	848.8MHz		
631000	RX	Channel 128	Channel 190	Channel 251		
		869.2MHz	881.6MHz	893.8MHz		
	тх	Channel 4132	Channel 4182	Channel 4233		
WCDMA850		826.4MHz	836.4MHz	846.6MHz		
WCDIMA050	RX	Channel 4357	Channel 4407	Channel 4458		
	КЛ	871.4MHz	881.4MHz	891.6MHz		
Test Mode	TX / RX	RF Channel				
Test Mode		Low (L)	Middle (M)	High (H)		
	тх	Channel 512	Channel 661	Channel 810		
GSM1900		1850.2MHz	1880.0MHz	1909.8MHz		
63111900	RX	Channel 512	Channel 661	Channel 810		
		1930.2 MHz	1960.0 MHz	1989.8 MHz		
WCDMA1900	тх	Channel 9262	Channel9400	Channel9538		
		1852.4MHz	1880.0MHz	1907.6MHz		
	RX	Channel 9662	Channel 9800	Channel 9938		
		1932.4 MHz	1960.0 MHz	1987.6 MHz		



Test Mode					
Test Mode	TX / RX	Low (B)	Middle (M)	High (T)	
	TX (5M)	Channel 20775	Channel 21100	Channel 21425	
		2502.5 MHz	2535 MHz	2567.5 MHz	
	TX (10M)	Channel 20800	Channel 21100	Channel 21400	
		2505 MHz	2535 MHz	2565 MHz	
	TX (15M)	Channel 20825	Channel 21100	Channel 21375	
	17 (1310)	2507.5 MHz	2535 MHz	2562.5 MHz	
	TX (20M)	Channel 20850 Channel 21100 Channel 2		Channel 21350	
LTE Band 7	TX (20101)	2510 MHz 2535 MHz 2560		2560 MHz	
	RX (5M)	Channel 2775	Channel 3100	Channel 3425	
		2622.5 MHz	2655 MHz	2687.5 MHz	
	RX (10M)	Channel 2800	Channel 3100	Channel 3400	
RX (10		2625 MHz	2655 MHz	2685 MHz	
	RX (15M)	Channel 2825	Channel 3100	Channel 3375	
		2627.5 MHz	2655 MHz	2682.5 MHz	
	RX (20M)	Channel 2850	Channel 3100	Channel 3350	
		2630 MHz	2655 MHz	2680 MHz	

4.4 DESCRIPTION OF TESTS

4.4.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-D-2010. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 3GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT.

The power of the emission is calculated using the following formula:

 $P_{d [dBm]} = P_{g [dBm]} - cable loss [dB] + antenna gain [dBd/dBi]$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log₁₀(Power [Watts]).

Test Procedures Used

KDB 971168 D01 v03-Section 5.2.2 / KDB 971168 D01 v03-Section 5.8

ANSI/TIA-603-D-2010-Section 2.2.17 / ANSI/TIA-603-D-2010-Section 2.2.12

Note: Reference test setup 3



4.4.2 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

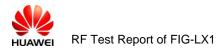
Test Procedures Used

KDB 971168 D01 v03-Section 5.7.2

Test Settings

- 1. The signal analyzer's CCDF measurement profile enabled
- 2、Frequency= carrier center frequency
- 3、Measurement BW > EBW of signal
- 4、 for continuous transmissions, set to 1ms
- 5、Record the maximum PAPR level associated with a probability of 0.1%.

Note: Reference test setup 1



4.4.3 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Test Procedures Used

KDB 971168 D01 v03-Section 4.3

Test Settings

- $1\,{\scriptstyle \smallsetminus}\,$ SET RBW=1-5% of OBW
- 2、SET VBW ≥ 3*RBW
- 3、Detector: Peak
- 4、Trace mode= max hold.
- 5. Sweep= auto couple
- 6、Steps 1-5 were repeated after it is stable

Note: Reference test setup 1.



4.4.4 Band Edge Compliance

the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission power must be attenuated below the transmitting power (P) by a factor of at least $43+10\log_{10}P$ dB.

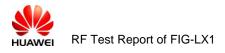
Test Procedures Used

KDB 971168 D01 v03-Section 6

Test Settings

- 1 \bigcirc SET RBW ≥ 1% of Emission BW.
- 2、SET VBW about three times of RBW
- 3、Detector: RMS
- 4、Trace mode= max hold.
- 5、Span= 2MHz

Note: Reference test setup 1.



4.4.5 Spurious and Harmonic Emissions at Antenna Terminal

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Test Procedures Used

KDB 971168 D01 v03-Section 6

Test Settings

1、9kHz~150kHz, RBW = 1KHz, VBW \geq 3×RBW,

150kHz~30MHz, RBW = 10KHz, VBW \geq 3×RBW,

30MHz~1GHz, RBW = 100 kHz, VBW = 300 kHz.

Above 1GHz, RBW = 1 MHz, VBW = 3 MHz.

- 2、Detector: Peak
- 3、Trace mode= max hold.

Note: Reference test setup 1.

4.4.6 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-D-2010. The frequency stability of the transmitter is measured by:

a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.

b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).

2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.

3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Procedures Used

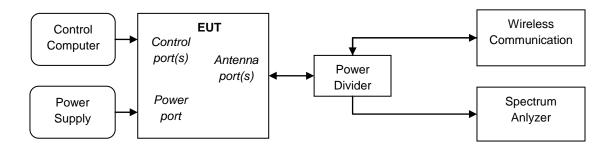
ANSI/TIA-603-D-2010

Note: Reference test setup 2.



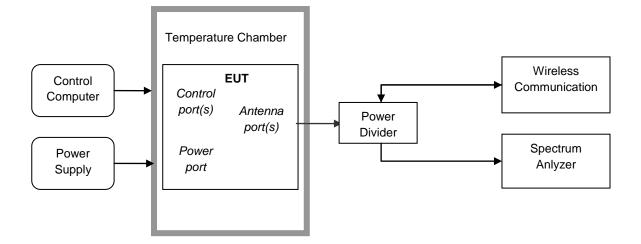
4.5 Test Setups

4.5.1 Test Setup 1





4.5.2 Test Setup 2

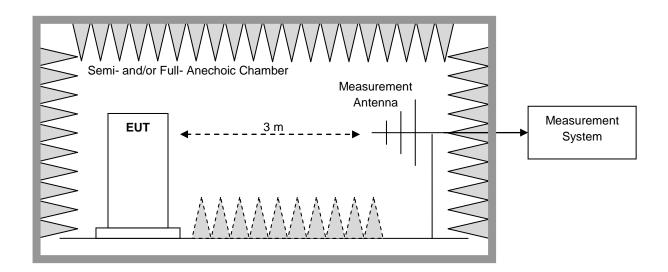




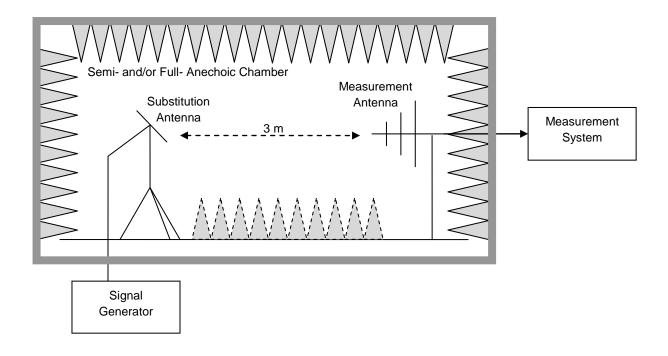
4.5.3 Test Setup 3

NOTE: Effective radiated power (ERP) and Equivalent Isotropic Radiated Power(EIRP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

4.5.3.1 Step 1: Pre-test



4.5.3.2 Step 2: Substitution method to verify the maximum ERP/EIRP



4.6 Test Conditions

Test Case Te		Test Condition	IS	
Transmit	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
Output	Total	Test Setup	Test Setup 1	
Power Data		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
	Spectral Density	Test Setup	Test Setup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Peak-to-Aver	age Ratio	Test Env.	Ambient Climate & Rated Voltage	
(if required)		Test Setup	Test Setup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Modulation C	haracteristics	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels	M	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Bandwidth	Occupied	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Setup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
	Emission	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Setup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Band Edges	Compliance	Test Env.	Ambient Climate & Rated Voltage	
RF C (TX)		Test Setup	Test Setup 1	
		RF Channels	L, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Spurious Emi	ssion at Antenna	Test Env.	Ambient Climate & Rated Voltage	
Terminals		Test Setup	Test Setup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	



Test Case	Test Condition	Test Conditions	
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Field Strength of Spurious	Test Env.	Ambient Climate & Rated Voltage	
Radiation	Test Setup	Test Setup 3	
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1/TM2/TM3,LTE/TM1,LTE/TM2	
		NOTE: If applicable, the EUT conf. that has maximum power	
		density (based on the equivalent power level) is	
		selected.	
	RF Channels	L, M, H	
	(TX)	(L= low channel, M= middle channel, H= high channel)	
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;	
		(2) VL, VN and VH of Rated Voltage at Ambient Climate.	
	Test Setup	Test Setup 2	
	RF Channels	L, M, H	
	(TX)	(L= low channel, M= middle channel, H= high channel) GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
	Test Mode		



5 Main Test Instruments

Main Test Equipments					
Equipment Name	Manufacturer	Model	Serial Number	Cal Dat	e Cal- Due
Power supply	KEITHLEY	2303	000500E	2017/5/3	31 2018/5/30
Wireless Communication Test set	Agilent	N4010A	MY49081592	2017/7/3	31 2018/7/30
Universal Radio Communication Tester	R&S	CMU200	117341	2016/12	/1 2017/11/30
Universal Radio Communication Tester	R & S	CMW500	126854	2017/10/	19 2018/10/18
Signal Analyzer	R&S	FSQ31	200021	2017/7/3	31 2018/7/30
Spectrum Analyzer	Agilent	N9030A	MY49431698	2017/7/3	31 2018/7/30
Temperature Chamber	WEISS	WKL64	56246002940010	2016/12/	21 2017/12/20
Signal generator	Agilent	E8257D	MY49281095	2017/7/3	31 2018/7/30
Vector Signal Generator	R&S	SMU200A	104162	2017/7/3	31 2018/7/30
Test receiver	R&S	ESU26	100387	2017/2/2	21 2018/2/20
Test receiver	R&S	ESCI	101163	2017/2/2	21 2018/2/20
Spectrum analyzer	R&S	FSU3	200474	2017/2/2	21 2018/2/20
Spectrum analyzer	R&S	FSU43	100144	2017/2/2	21 2018/2/20
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100262	2017/4/2	25 2019/4/25
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100263	2017/4/2	25 2019/4/25
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-490	2017/3/2	29 2019/3/29
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-521	2017/4/	9 2019/4/9
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2017/5/2	27 2019/5/27
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgren	3160-09	206665	2017/3/2	24 2018/3/23
Artificial Main Network	R&S	ENV4200	100134	2017/5/1	15 2018/5/14
Line Impedance Stabilization Network	R&S	ENV216	100382	2017/5/1	15 2018/5/14
Signal Generator	Agilent	E4438C	MY49071538	2016/12/	15 2017/12/14
Power Detecting & Sampling Unit	R&S	OSP-B157	100914	2017/7/3	31 2018/7/30
	Sof	tware Inform	ation		·
Test Item	Software Name	;	Manufacturer		Version
RSE	EMC32		R&S		V8.40.0



6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	
Transmit Output Power Data Power [dBm]		U = 0.42 dB
Bandwidth	Magnitude [%]	U = 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = 1.24 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = 1.62 dB
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber:
		U = 4.9 dB (30 MHz to 26.5GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = 0.017 ppm

7 Appendixes

Appendix No.	Description
SYBH(Z-RF)0011120172001-A	Appendix_for_GSM
SYBH(Z-RF)001112017-2001-B	Appendix_for_WCDMA
SYBH(Z-RF)001112017-2001-C	Appendix_for_LTE Band7

Appendix	Description	
Appendix A	Effective (Isotropic) Radiated Power Output Data	
Appendix B	Peak-Average Ratio	
Appendix C	Modulation Characteristics	
Appendix D	Bandwidth	
Appendix E	Band Edges Compliance	
Appendix F	Spurious Emission at Antenna Terminals	
Appendix G	Field Strength of Spurious Radiation	
Appendix H	Frequency Stability	

END